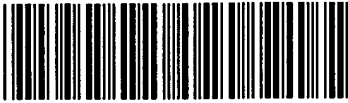


**Search Notes**

Application/Control No.

10/032,576

Examiner

Neeraj Bhatia

Applicant(s)/Patent under  
Reexamination

CHO ET AL.

Art Unit

2661

**SEARCHED**

Class	Subclass	Date	Examiner
370	468,455, 335,342, 465,252	9/12/2005	NB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/252,335,342,455,465,468 (text search only- see search history printout)	9/12/2005	NB
EAST: US-PG PUB;USPAT;USOCR (text search only - see search history printout)	9/12/2005	NB